

**Search Notes**

Application/Control No.

09/820,095

Examiner

Brian Whiteman

Applicant(s)/Patent under  
Reexamination

WEI ET AL.

Art Unit

1635

**SEARCHED**

Class	Subclass	Date	Examiner
536	23.1,23.2	11/10/2005	BW
536	23.5		BW
435	320.1		BW
435	325,455		
435	243,348		
435	353,354		
435	410,358		
435	254.11		
435	252.3		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
536	23.1,23.2	11/10/2005	BW
536	23.5		
435	320.1		
435/325,435/455; 435/243,435/348			

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STIC updated seq. search	11/14/2005	BW

**Search Notes (continued)**

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**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
435	353,354	11/10/2005	BW
435	410,358	↓	↓
435	254.11	↓	↓
STIC performed interference search		11/14/2005	BW

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR